

# FQB5N80 / FQI5N80 800V N-Channel MOSFET

### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

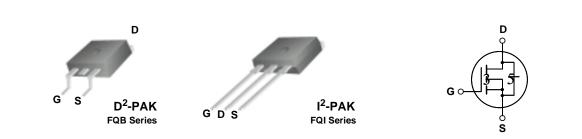
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

#### Features

September 2000

ТМ

- 4.8A, 800V,  $R_{DS(on)} = 2.6\Omega @V_{GS} = 10 V$  Low gate charge ( typical 25 nC)
- Low Crss (typical 11 pF) •
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



## Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB5N80 / FQI5N80	Units	
V <sub>DSS</sub>	Drain-Source Voltage		800	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	4.8	А	
	- Continuous (T <sub>C</sub> = 100	)°C)	3.04	А	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	19.2	А	
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	590	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	4.8	А	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	14	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.0	V/ns	
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.13	W	
	Power Dissipation $(T_C = 25^{\circ}C)$		140	W	
	- Derate above 25°C		1.12	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

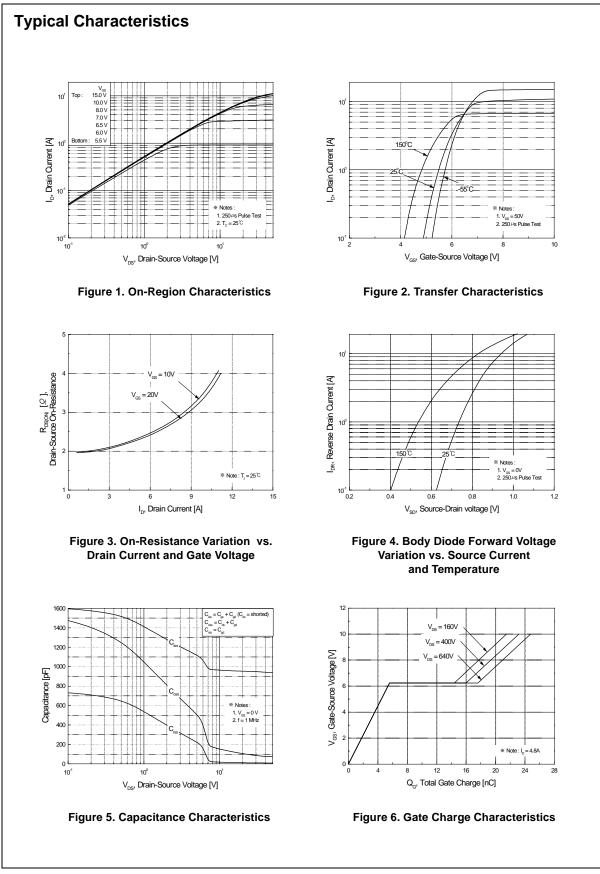
## **Thermal Characteristics**

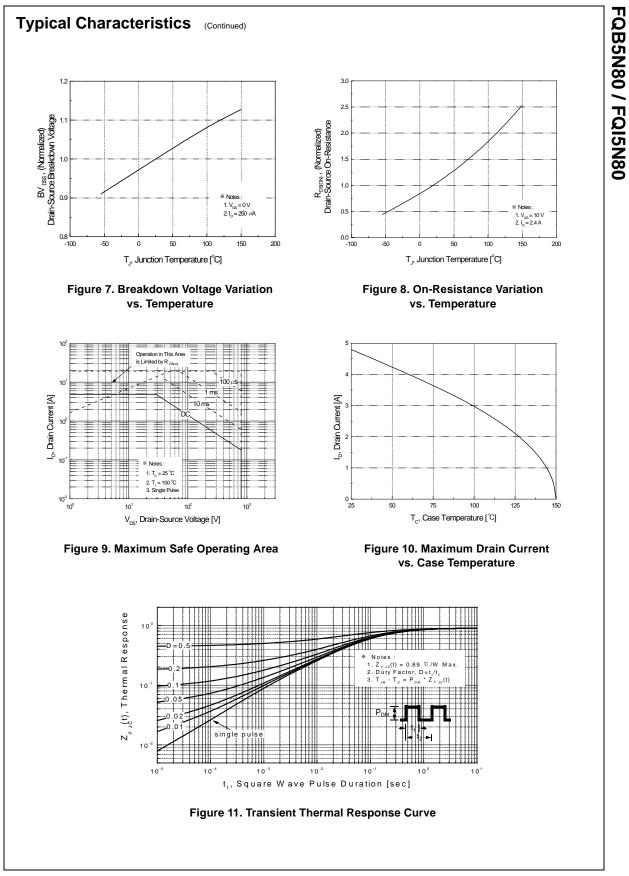
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.89	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

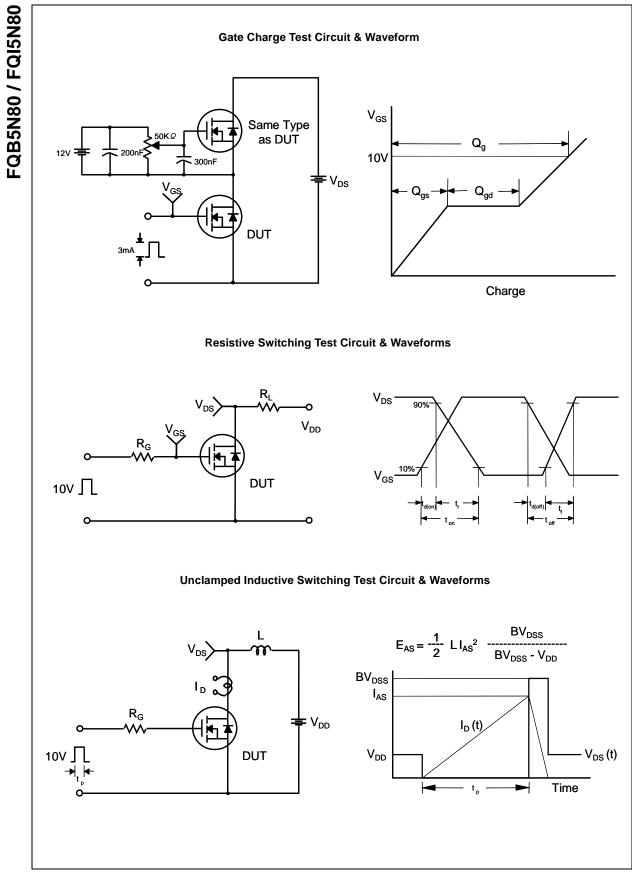
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	racteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	800			V
ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to 2	5°C	0.9		V/°C
DSS		V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V			10	μA
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C			100	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
on Cha	restariation	1	k			
Jn Cna / <sub>GS(th)</sub>	racteristics Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.4 \text{ A}$		2.0	2.6	Ω
JFS	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 2.4 \text{ A}$ (No	te 4)	4.9		S
Piss Poss Prss	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		950 95 11	1250 125 15	pF pF pF
Switchi	ng Characteristics	L	I	1		
d(on)	Turn-On Delay Time	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 4.8 A,		22	55	ns
r	Turn-On Rise Time	$R_{G} = 25 \Omega$		60	130	ns
d(off)	Turn-Off Delay Time	1.6 - 20 32		55	120	ns
:	Turn-Off Fall Time	(Note		40	90	ns
λ <sup>g</sup>	Total Gate Charge	V <sub>DS</sub> = 640 V, I <sub>D</sub> = 4.8 A,		25	33	nC
ک <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		5.6		nC
ک <sub>gd</sub>	Gate-Drain Charge	(Note		12		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings				
S	Maximum Continuous Drain-Source Dic				4.8	А
SM	Maximum Pulsed Drain-Source Diode Forward Current				19.2	Α
/ <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 4.8 A$			1.4	V
rr	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 4.8 A,		610		ns
۵ <sub>rr</sub>	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A}/\mu \text{s}$ (No	te 4)	4.7		μC
L = 48mH, I <sub>/</sub>	ating : Pulse width limited by maximum junction temper $_{IS} = 4.8A, V_{DD} = 50V, R_G = 25 \Omega, Starting T_J = 25°C$ di/dt $\leq 200A/\mu S, V_{DD} \leq BV_{DSS}$ , Starting T_J = 25°C	rature				

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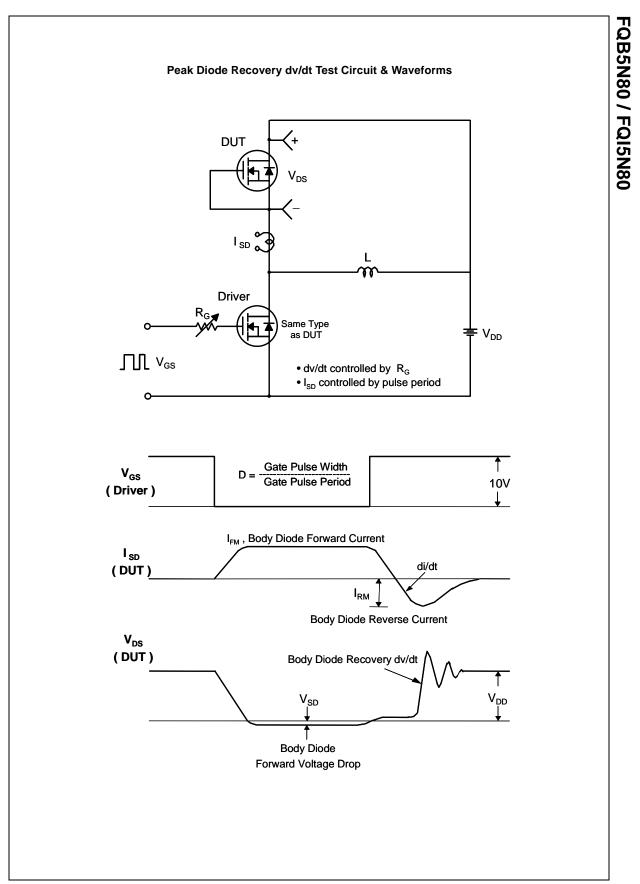




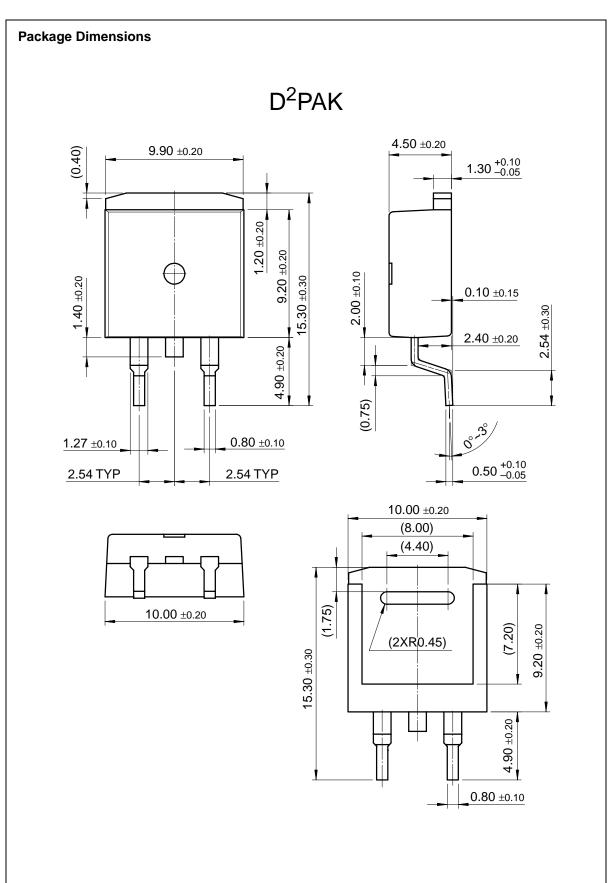


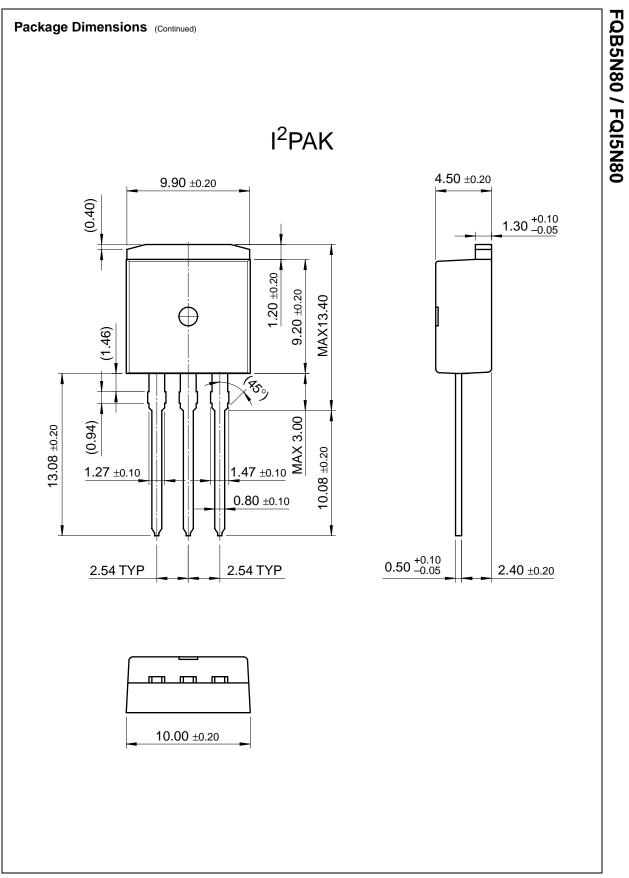


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Datasheet Identification	Product Status	Definition
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find productsProducts groupsAnalog and MixedSignalDiscreteInterfaceLogicMicrocontrollersNon-VolatileMemoryOptoelectronicsMarkets andapplicationsNew productsProduct selection andparametric searchCross-referencesearch	Home >> Find products >>         FQI5N80         800V N-Channel QFET         Contents         General description   Features   Product         status/pricing/packaging         General description         General description         These N-Channel enhancement mode power         field effect transistors are produced using         Fairchild's proprietary, planar stripe, DMOS         technology.         This advanced technology has been especially         tailored to minimize on-state resistance,         provide superior switching performance, and         withstand high energy pulse in the avalanche	Datasheet   Download this   datasheet   PDF   e-mail this datasheet [E- This page Print version	duct Folders and Annlies
technical information buy products technical support my Fairchild	and commutation mode. These devices are well suited for high efficiency switch mode power supply.	_	
company	Features		

- 4.8A, 800V,  $R_{DS(on)} = 2.6\Omega @V_{GS} = 10$ V
- Low gate charge (typical 25 nC)
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- Fast switching
- 100% avalanche tested
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## back to top

Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQI5N80TU	Full Production	\$1.12	TO-262(I2PAK)	3	RAIL

\* 1,000 piece Budgetary Pricing

back to top

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